

Head TSL parameters at 5300 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.9	4.76 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.7 ±6%	4.60 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	80.6 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.33 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	23.3 W/kg ±19.5% (k = 2)

Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.6	4.96 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.3 ±6%	4.82 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.56 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	85.6 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.45 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.5 W/kg ±19.5% (k = 2)

Head TSL parameters at 5600 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.5	5.07 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	35.1 ±6%	4.94 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	8.33 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	83.3 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.41 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	24.1 W/kg ±19.5% (k = 2)

Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ±0.2)°C	34.9 ±6%	5.15 mho/m ±6%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	7.90 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	79.0 W/kg ±19.9% (k = 2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR for nominal Head TSL parameters	20 dBm input power	2.27 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	22.7 W/kg ±19.5% (k = 2)

Appendix (Additional assessments outside the scope of SCS 0108)**Antenna Parameters with Head TSL at 5200 MHz**

Impedance	53.3 Ω – 4.8 j Ω
Return Loss	-25.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance	48.4 Ω + 2.0 j Ω
Return Loss	-31.6 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance	47.6 Ω – 2.2 j Ω
Return Loss	-29.5 dB

Antenna Parameters with Head TSL at 5600 MHz

Impedance	55.9 Ω + 0.5 j Ω
Return Loss	-25.1 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance	50.5 Ω + 4.2 j Ω
Return Loss	-27.5 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.207 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5200	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5200, 0	5.68	4.51	35.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	7.60
psSAR10g [W/Kg]	2.20
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 30.4 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5300	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5300, 0	5.45	4.60	35.7

Hardware Setup

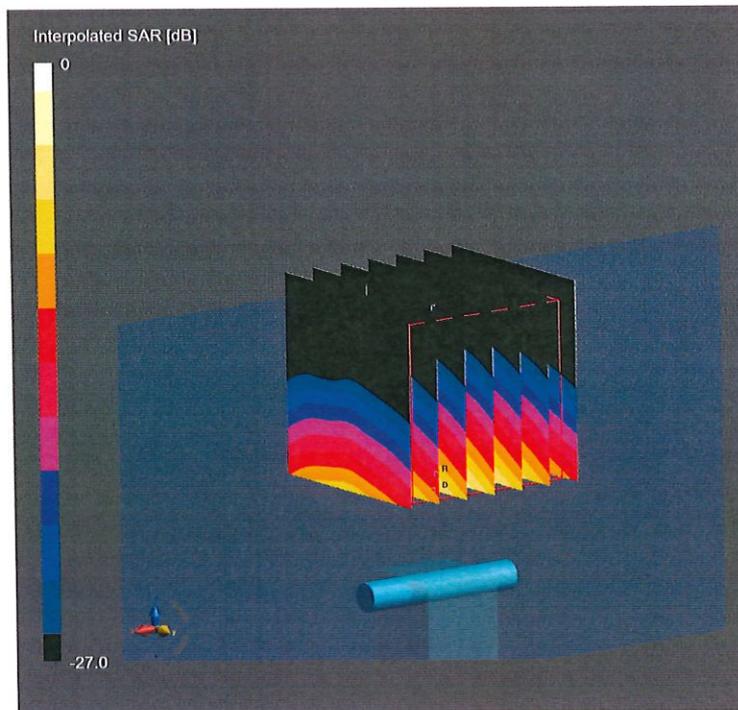
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR 1g [W/Kg]	8.06
psSAR 10g [W/Kg]	2.33
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 33.1 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5500	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5500, 0	5.07	4.82	35.3

Hardware Setup

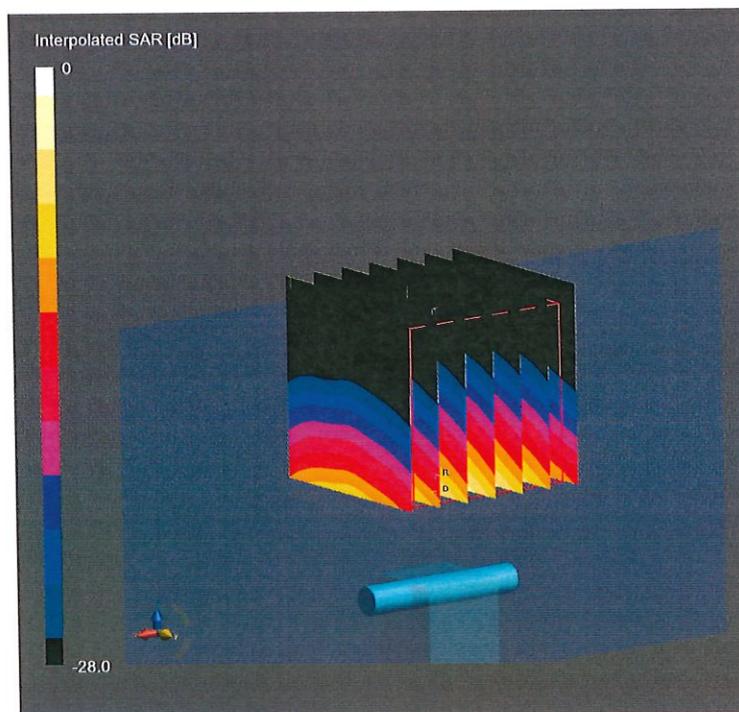
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.56
psSAR10g [W/Kg]	2.45
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 36.7 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5600	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5600, 0	5.03	4.94	35.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR1g [W/Kg]	8.33
psSAR10g [W/Kg]	2.41
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 36.3 W/Kg

System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D5GHzV2 - SN1412	5800	HSL	20

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10		CW, 0--	5800, 0	5.08	5.15	34.9

Hardware Setup

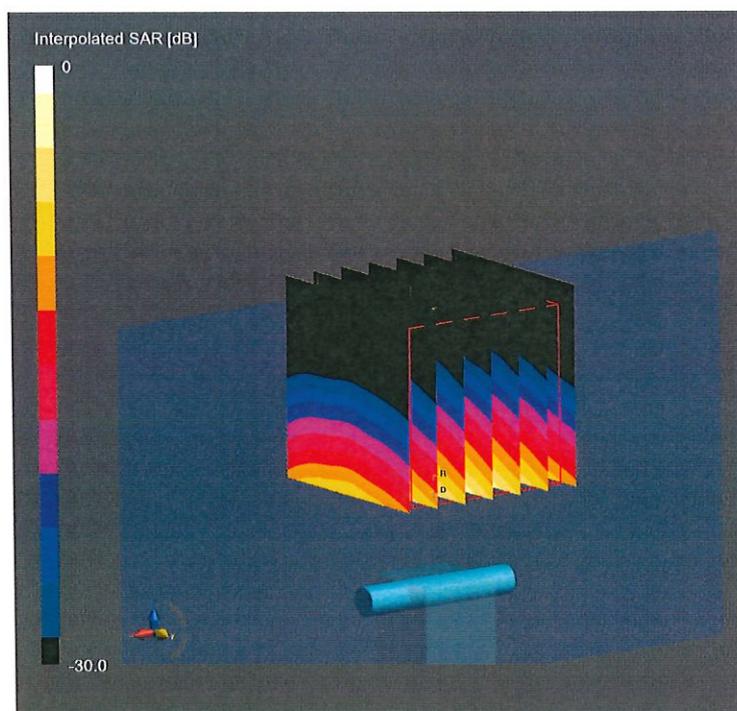
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2024-10-17	EX3DV4 - SN7349, 2024-06-03	DAE4ip Sn1836, 2024-01-10

Scans Setup

	Zoom Scan
Grid Extents [mm]	22 x 22 x 22
Grid Steps [mm]	4.0 x 4.0 x 1.4
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.4
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2024-10-17
psSAR 1g [W/Kg]	7.90
psSAR 10g [W/Kg]	2.27
Power Drift [dB]	-0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative

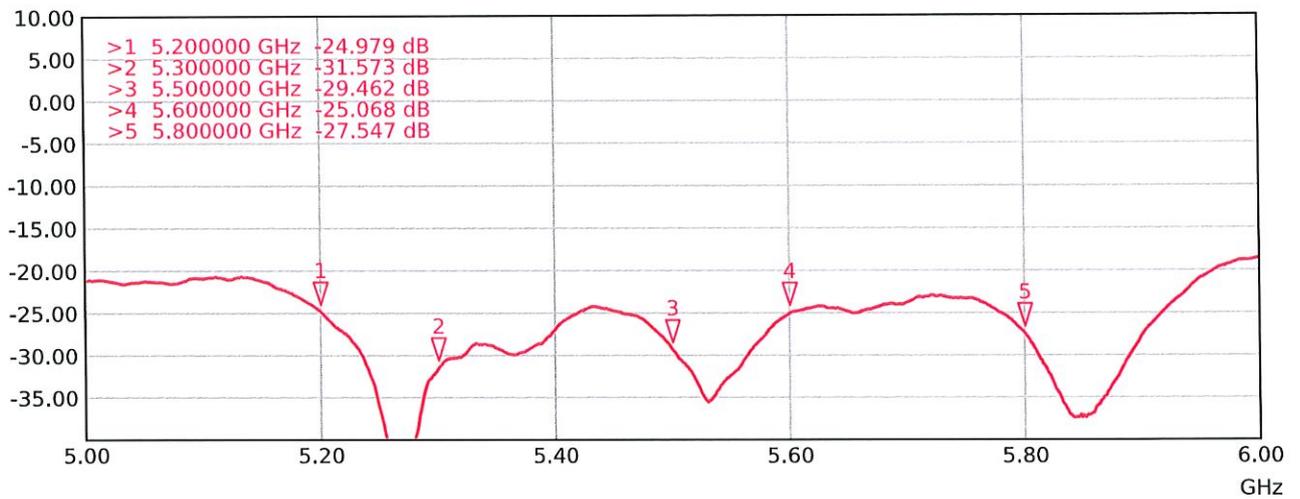
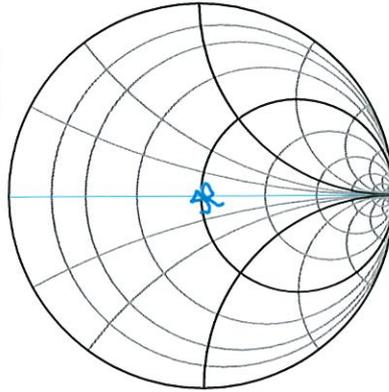


0 dB = 36.0 W/Kg

Impedance Measurement Plot for Head TSL

S11 Smith (R+jX) Scale 1.00

>1	5.200000 GHz	53.331 Ω	-4.787 $j\Omega$
>2	5.300000 GHz	48.405 Ω	2.049 $j\Omega$
>3	5.500000 GHz	47.552 Ω	-2.187 $j\Omega$
>4	5.600000 GHz	55.889 Ω	0.477 $j\Omega$
>5	5.800000 GHz	50.472 Ω	4.191 $j\Omega$





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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **WSCT**
Shenzhen

Certificate No: **DAE4ip-1872_Oct24**

CALIBRATION CERTIFICATE

Object **DAE4ip - SD 000 D14 AG - SN: 1872**

Calibration procedure(s) **QA CAL-06.v30
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **October 18, 2024**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	27-Aug-24 (No:40547)	Aug-25
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-24 (in house check)	In house check: Jan-25
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by:	Name Adrian Gehring	Function Laboratory Technician	Signature
Approved by:	Name Sven Kühn	Function Technical Manager	Signature

Issued: October 18, 2024

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Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.516 \pm 0.02% (k=2)	405.743 \pm 0.02% (k=2)	405.517 \pm 0.02% (k=2)
Low Range	3.97808 \pm 1.50% (k=2)	3.99468 \pm 1.50% (k=2)	3.97864 \pm 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	206.5 $^{\circ}$ \pm 1 $^{\circ}$
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199998.14	1.11	0.00
Channel X + Input	20003.88	1.08	0.01
Channel X - Input	-20001.65	0.61	-0.00
Channel Y + Input	199999.84	2.82	0.00
Channel Y + Input	20001.02	-1.73	-0.01
Channel Y - Input	-20002.12	0.19	-0.00
Channel Z + Input	199995.41	-1.01	-0.00
Channel Z + Input	20001.78	-0.94	-0.00
Channel Z - Input	-20002.55	-0.24	0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.17	-0.31	-0.02
Channel X + Input	202.08	0.64	0.32
Channel X - Input	-197.21	0.83	-0.42
Channel Y + Input	2001.25	0.08	0.00
Channel Y + Input	201.01	-0.31	-0.16
Channel Y - Input	-198.91	-0.55	0.28
Channel Z + Input	2001.51	0.45	0.02
Channel Z + Input	200.43	-0.89	-0.44
Channel Z - Input	-199.69	-1.39	0.70

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	19.34	18.17
	- 200	-17.47	-18.30
Channel Y	200	6.89	6.47
	- 200	-6.94	-7.73
Channel Z	200	10.21	9.75
	- 200	-12.83	-12.52

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.42	-2.57
Channel Y	200	5.19	-	2.08
Channel Z	200	8.69	2.55	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15797	17374
Channel Y	16064	13550
Channel Z	15971	14566

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.67	0.01	1.30	0.27
Channel Y	-0.40	-1.22	0.56	0.36
Channel Z	-0.58	-1.57	0.50	0.51

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

Client : **WSCT**

Certificate No: **24J02Z000415**

CALIBRATION CERTIFICATE

Object: **DAE4 - SN: 1495**

Calibration Procedure(s): **FF-Z11-002-01**
Calibration Procedure for the Data Acquisition Electronics (DAEx)

Calibration date: **July 24, 2024**

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Process Calibrator 753	1971018	11-Jun-24 (CTTL, No.24J02X005147)	Jun-25

	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: August 01, 2024

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Glossary:

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other performance test results.



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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.380 \pm 0.15% (k=2)	404.618 \pm 0.15% (k=2)	404.873 \pm 0.15% (k=2)
Low Range	3.96611 \pm 0.7% (k=2)	3.97363 \pm 0.7% (k=2)	3.99493 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	109 $^{\circ}$ \pm 1 $^{\circ}$
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Client **WSCT**

Certificate No: **24J02Z000487**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN : 7391**

Calibration Procedure(s) **FF-Z11-004-02**
Calibration Procedures for Dosimetric E-field Probes

Calibration date: **August 29, 2024**

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	106277	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Power sensor NRP8S	104291	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Power sensor NRP8S	104292	19-Oct-23(CTTL, No.J23X11026)	Oct-24
Reference 10dBAttenuator	18N50W-10dB	19-Jan-23(CTTL, No.J23X00212)	Jan-25
Reference 20dBAttenuator	18N50W-20dB	19-Jan-23(CTTL, No.J23X00211)	Jan-25
Reference Probe EX3DV4	SN 7307	28-May-24(SPEAG, No.EX-7307_May24)	May-25
DAE4	SN 771	19-Jan-24(SPEAG, No.DAE4-771_Jan24)	Jan-25
Secondary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
SignalGenerator MG3700A	6201052605	12-Jun-24(CTTL, No.24J02X005419)	Jun-25
SignalGenerator APSIN26G	181-33A6D0700-1959	26-Mar-24(CTTL, No.24J02X002468)	Mar-25
Network Analyzer E5071C	MY46110673	25-Dec-23(CTTL, No.J23X13425)	Dec-24
Reference 10dBAttenuator	BT0520	11-May-23(CTTL, No.J23X04061)	May-25
Reference 20dBAttenuator	BT0267	11-May-23(CTTL, No.J23X04062)	May-25
OCP DAK-12	SN 1174	25-Oct-23(SPEAG, No.OCP-DAK12-1174_Oct23)	Oct-24

	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Lin Jun	SAR Test Engineer	
Approved by:	Qi Dianyuan	SAR Project Leader	

Issued: September 07, 2024

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In Collaboration with

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Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), $\theta=0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- IEC 62209-1, "Measurement procedure for the assessment of Specific Absorption Rate (SAR) from hand-held and body-mounted devices used next to the ear (frequency range of 300 MHz to 6 GHz)", July 2016
- IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta=0$ ($f \leq 900\text{MHz}$ in TEM-cell; $f > 1800\text{MHz}$: waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}; A,B,C** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800\text{MHz}$) and inside waveguide using analytical field distributions based on power measurements for $f > 800\text{MHz}$. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from $\pm 50\text{MHz}$ to $\pm 100\text{MHz}$.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7391

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.35	0.32	0.34	±10.0%
DCP(mV) ^B	101.8	106.3	99.8	

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max Dev.	Max Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	146.3	±2.7%	±4.7%
		Y	0.0	0.0	1.0		141.5		
		Z	0.0	0.0	1.0		143.2		
10352-AAA	Pulse Waveform (200Hz, 10%)	X	1.32	60.00	4.99	10.00	60	±5.2%	±9.6%
		Y	1.47	60.85	6.63		60		
		Z	1.31	60.00	5.20		60		
10353-AAA	Pulse Waveform (200Hz, 20%)	X	36.00	72.00	7.00	6.99	80	±4.2%	±9.6%
		Y	0.82	60.00	4.99		80		
		Z	14.00	70.00	7.00		80		
10354-AAA	Pulse Waveform (200Hz, 40%)	X	0.00	69.19	37.94	3.98	95	±4.6%	±9.6%
		Y	0.05	60.00	100.00		95		
		Z	0.00	69.91	38.60		95		
10355-AAA	Pulse Waveform (200Hz, 60%)	X	0.00	92.27	100.00	2.22	120	±5.5%	±9.6%
		Y	0.02	60.00	100.00		120		
		Z	0.00	90.64	99.97		120		
10387-AAA	QPSK Waveform, 1 MHz	X	20.00	126.25	38.29	1.00	150	±3.6%	±9.6%
		Y	20.00	123.70	37.08		150		
		Z	20.00	132.56	41.66		150		
10388-AAA	QPSK Waveform, 10 MHz	X	20.00	118.30	36.15	0.00	150	±3.3%	±9.6%
		Y	20.00	116.69	35.33		150		
		Z	20.00	121.31	37.90		150		
10396-AAA	64-QAM Waveform, 100 kHz	X	10.12	112.49	39.41	3.01	150	±2.2%	±9.6%
		Y	6.92	101.30	35.39		150		
		Z	20.00	130.56	45.18		150		
10414-AAA	WLAN CCDF, 64-QAM, 40MHz	X	5.24	69.75	18.68	0.00	150	±3.7%	±9.6%
		Y	5.14	69.21	18.25		150		
		Z	5.28	70.02	18.92		150		

Note: For details on UID parameters see Appendix

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7391

Sensor Model Parameters

	C1 fF	C2 fF	α V ⁻¹	T1 ms.V ⁻²	T2 ms.V ⁻¹	T3 ms	T4 V ⁻²	T5 V ⁻¹	T6
X	31.12	230.42	36.27	4.26	0.00	4.90	0.00	0.17	1.02
Y	30.26	220.54	35.20	5.72	0.00	5.03	0.25	0.13	1.02
Z	30.51	224.99	36.20	5.41	0.00	4.93	0.28	0.15	1.02

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	118.6
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm